

Search Notes

Application/Control No.

10/649,321

Examiner

Khanh V. Nguyen

Applicant(s)/Patent under
Reexamination

THEUS ET AL.

Art Unit

2817

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
See Search History Printout		5/25/2006	NKV

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
330/141,150,281,302,310; 327/148, 157,536 (Partial Search)	3/18/2004	NKV
EAST (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB)	6/25/2006	NKV